Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/543,092	MIYAMATSU ET AL.	
Examiner	Art Unit	
John S. Chu	1795	

	SEARCHED					
Class	Subclass	Date	Examiner			
430	270.1	12/2017	J4:-			
430	905	1	1			
430	910					
430	922					
549	13					
549	29					
549	88					
549	90					
568	27					
568	28	/				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
430	270.1,905	12/2007	Js c		
430	910,922		1		
549	13,29,88				
549/90;5	68/27,28	7			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
UPDATED	12 /200	, Jsc		
<u>. </u>		-		